

XA-10578

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

FUKUDA, Keiko et al.

Intl. Appln. No.: PCT/JP2004/017910

Intl. Filing Date: 2 December 2004

For: VOLTAGE GENERATION CIRCUIT AND SEMICONDUCTOR INTEGRATED
CIRCUIT DEVICEINFORMATION DISCLOSURE STATEMENTCommissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450Attn: Mail Stop PCT, DO/EO/US

Sir:

Pursuant to 37 C.F.R. § 1.56, and without any assertion as to materiality or prior art effect, the documents listed on the attached Form PTO-1449 are hereby cited.

Documents AA and AO-AP on the attached List were cited in the specification, on pages 1-2 and 10, and their relevance is indicated therein. Documents AE-AG were cited in the International Search Report (copy attached).

Respectfully submitted,

MWS:sjk

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June 23, 2006

FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT LIST OF DOCUMENTS CITED BY APPLICANTS				Atty. Docket No. XA-10578		Appln. No. 10/584395	
				Applicant FUKUDA, Keiko et al.			
				Filing Date HEREWITH		Group	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
	AA	3,887,863	06/03/75	Brokaw	323	19	
	AB	2003/0094933	05/22/03	Yamamoto	323	313	
	AC						
	AD						
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
	AE	58-109912	06/30/83	Japan			Abstract
	AF	11-143563	05/28/99	Japan			Abstract
	AG	2003-157119	05/30/03	Japan (corrs. to Doc. AB)			Abstract
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
OTHER (including author, title, date, pertinent pages, etc.)							
	AO	K. Kuijk, "A Precision Reference Voltage Source," IEEE Journal of Solid-State Circuits, Vol. SC-8, No. 3, June 1973, pp. 222-226.					
	AP	P. Brokaw, "A simple Three-Terminal IC Bandgap Reference," IEEE Journal of Solid-State Circuits, Vol. SC-9, No. 6, December 1974, pp. 388-393.					
Examiner				Date Considered			
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							